Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | NAKANISHI ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,338,607 A	07-1982	Drabowitch, Serge	343/754
*	В	US-5,467,283 A	11-1995	Butsuen et al.	701/301
*	C	US-5,926,126 A	07-1999	Engelman, Gerald H.	342/70
*	D	US-2002/0190895 A1	12-2002	Nakanishi et al.	342/146
*	E	US-2003/0102998 A1	06-2003	Ishii et al.	342/70
*	F	US-2003/0151544 A1	06-2003	Nishimura et al.	342/70
*	G	US-6,621,448 B1	09-2003	Lasky et al.	342/22
*	Н	US-2003/0184470 A1	10-2003	Ishii et al.	342/174
*	-	US-2003/0210172 A1	11-2003	Pleva et al.	342/70
*	J	US-2005/0174282 A1	08-2005	Nakanishi et al.	342/109
*	K	US-2006/0109168 A1	05-2006	Nakanishi et al.	342/070
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2041687 A	09-1980	United Kingdom	MILNE et al	
	0	JP 58132676 A	08-1983	Japan	KIMURA, YASUJI	
	Р	JP 59211878 A	11-1984	Japan	KIUCHI et al.	
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.